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Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/506,363	YOSHIKAWA ET AL.	•
Examiner	Art Unit	· · · · · · · · · · · · · · · · · · ·
Pranav V. Khatri	2872	

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Class	Subclass	Date	Examiner
359	196	9/23/2005	PVK
359	202	9/23/2005	PVK
359	205	9/23/2005	PVK
359	208	9/23/2005	PVK
359	212	3/9/2006	PVK
359	. 214	3/9/2006	PVK

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Consulted with Primay examiner James Phan in regards to allowable subject matter.	3/9/2006	PVK	
Update Search	9/9/2006	PVK	
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